

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/811,856	NAKANO ET AL.		
Examiner	Art Unit		
Yaima Campos	. 2185		

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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